

Enhancement Mode P-Channel Power MOSFET

SOT23/PMOS/-30V/ \pm 20V/-1.8V/-4.1A/37m Ω

Rev1.0





-30V, 37mΩ, -4.1A, P-Channel MOSFET

1.Features

- Advanced Trench Technology
- ◆ Surface mount package

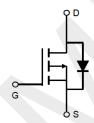
2.Applications

- Power Management
- Load Switching



SOT23 Pin Description

V_{DS} $R_{DS(on)}$ Typ. I_{D} . -30V $37m\Omega$ @ -10V -4.1A



Schematic Diagram

3. Package Marking and Ordering Information

Part no.	Marking	Package	PCS/Reel	PCS/CTN.	
WP3407ASS	3407A	SOT23	3,000	180,000	

4.Absolute Max Ratings at Ta=25°C (Note1)

Parameter	Symbol	Maximum	Units	
Drain to Source Voltage	V _{DSS}	-30	V	
Gate to Source Voltage	V_{GSS}	±20	V	
Drain Current (DC)	I _D	-4.1	А	
Drain Current (Pulse), PW≤300μs	I _{DP}	-16.4	А	
Total Dissipation	P _D	1.4	W	
Junction Temperature	Tj	150	°C	
Storage Temperature	T_{stg}	-55 to +150	°C	

Note 1: Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

5.Thermal Resistance Ratings (Note 2)

Parameter	Symbol	Value	Unit
Thermal Resistance, Junction-to-Ambient	R _θ ЈА	89	°C/W

Note 2: When mounted on 1 inch square copper board $t \le 10$ sec The value in any given application depends on the user's specific board design.



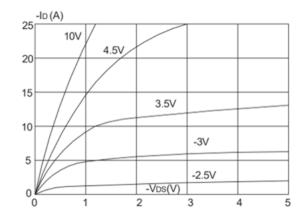
6.Electrical Characteristics at Ta=25°C (Note 3)

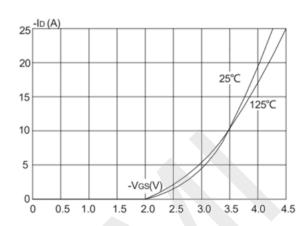
Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Units
Drain to Source Breakdown Voltage	V _{(BR)DSS}	$I_D = -250 \mu A$, $V_{GS} = 0 V$	-30			V
Zero-Gate Voltage Drain Current	I _{DSS}	V _{DS} = -30V, V _{GS} = 0V			-1	μA
Gate to Source Leakage Current	I _{GSS}	$V_{GS} = \pm 20V, V_{DS} = 0V$			±100	nA
Gate Threshold Voltage	$V_{GS(th)}$	V _{DS} =V _{GS} , I _{DS} =-250μA	-1.0	-1.8	-2.5	V
Static Drain to Source On-State	R _{DS(on)}	I _D =-4A, V _{GS} =-10V		37	50	mΩ
Resistance		I _D =-3A, V _{GS} =-4.5V		51	65	mΩ
Input Capacitance	C _{iss}	V _{GS} =0V,		580		pF
Output Capacitance	Coss	V _{DS} =-15V,		98		pF
Reverse Transfer Capacitance	Crss	Frequency=1.0MHz		74		pF
Turn-ON Delay Time	t _{d(on)}	V_{DS} =-15V, I_{D} =-1A, R_{G} = 2.5 Ω , V_{GS} = -10V		7	,	ns
Rise Time	t _r			4		ns
Turn-OFF Delay Time	t _{d(off)}			18		ns
Fall Time	t _f			13		ns
	Qg	V _{DS} = -15V, V _{GS} = -10V,		11		nC
Total Gate Charge	Qgs			1.9		nC
	Q _{gd}	I _D = -4.1A		2		nC
Diode Forward Voltage	V _{FSD}	I _S = -4.1A, V _{GS} = 0			-1.2	V

Note 3: Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.



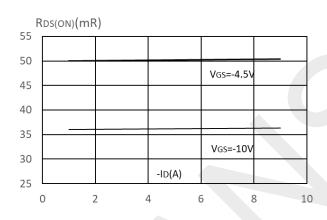
7. Typical Electrical and Thermal Characteristics

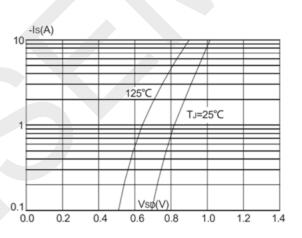




Output Characteristics

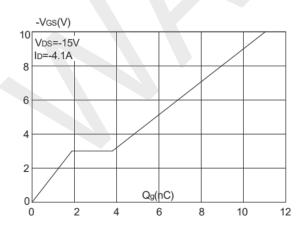
Typical Transfer Characteristics

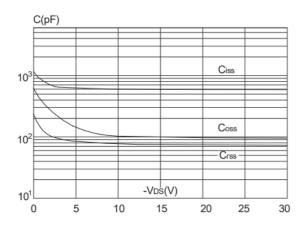




On-resistance vs. Drain Current

Body Diode Characteristics

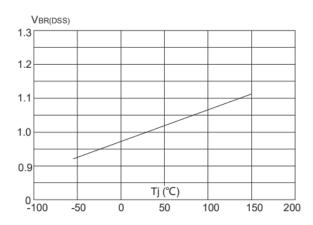




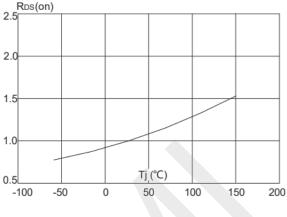
Gate Charge Characteristics

Capacitance Characteristics

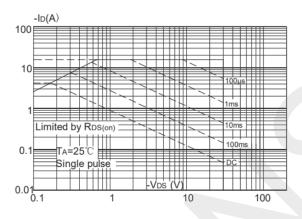




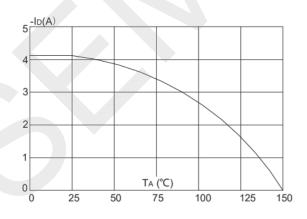
Normalized Breakdown Voltage vs. Junction Temperature



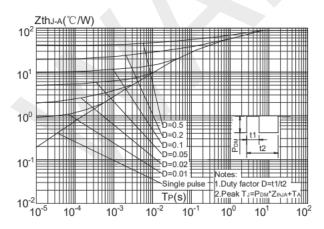
Normalized on Resistance vs.Junction Temperature



Maximum Safe Operating Area



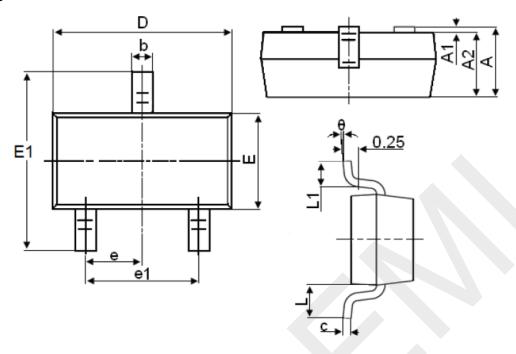
Maximum Continuous Drain Current vs.
Ambient Temperature



Maximum Effective Transient Thermal Impedance, Junction-to-Ambient



8.Package Dimensions



	Dimensions in Millimeters				
Symbol	MIN.	TYP.	MAX.		
А	0.900		1.150		
A1 .	0.000		0.100		
A2	0.900		1.050		
b	0.300		0.500		
С	0.080		0.150		
D	2.800		3.000		
E	1.200		1.400		
E1	2.250		2.550		
е		0.950			
e1	1.800		2.000		
L		0.550			
L1	0.300		0.500		
θ	0°		8°		



9.Important Notice

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